



CVE-2022-35858

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Summary

CVE	CVE-2022-35858
State	PUBLIC
Assigner	cve@mitre.org
Source Priority	CVE Program / NVD first with legacy fallback
Published	2022-08-04 20:15:00 UTC
Updated	2022-08-10 18:05:00 UTC
Description	The TEE_PopulateTransientObject and __utee_from_attr functions in Samsung mTower 0.3.0 allow a trusted application to

Risk And Classification

Problem Types: CWE-401

NVD Known Affected Configurations (CPE 2.3)

Type	Vendor	Product	Version	Update	Edition	Language
Application	Samsung	Mtower	0.3.0	All	All	All

References

Reference	Source	Link
mTower/tee_api_objects.c at 18f4b592a8a973ce5972f4e2658ea0f6e3686284 · Samsung/mTower · GitHub	MISC	github.com
Security: Memory Leak in the function TEE_PopulateTransientObject · Issue #71 · Samsung/mTower · GitHub	MISC	github.com
CVE Program record	CVE.ORG	www.cve.org
NVD vulnerability detail	NVD	nvd.nist.gov

No vendor comments have been submitted for this CVE.

There are currently no legacy QID mappings associated with this CVE.

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